



Investigation of pulsed D.C magnetron sputtering for the component layers of CulnSe₂ based solar cells

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Introduction

CIS/CIGS thin film based solar cells are the most promising renewable energy source because of their relatively high solar efficiency and stability. Single crystal Si cells need more material to absorb light due to its indirect band gap. In CIS the defect mechanisms makes it a direct semiconducting materials and no doping is needed.

Presently CIGS cells have achieved a maximum efficiency of 20.3% [1].

A typical cell CIS/CIGS structure is in the form of a heterojunction.



References

A typical CIGS solar cell

[1] P. Jackson et. al Progress in Photovoltaics: Research and Applications, (2011) EU PVSEC WCPEC-5, Valencia, Spain, 2010.

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Introduction

The first published report of a $CuInSe_2$ thin film was by the R.D Tomlinson group at the University of Salford in 1974 [2].

Films of CIS are generally made by multi-step processes

My work has been focussed on a **SINGLE STEP** process which can deposit films with.

- ✓ Nearly stoichiometric ratio.
- ✓ p-type characteristics.
- ✓ No secondary phases.
- \checkmark No additional substrate heating for crystallisation.
- ✓ Less material wastage.
- ✓ No carbon, oxygen, chlorine etc. contamination.

This work reports such a single step deposition process for nearly stoichiometric p-type CIS layers and also for the other component layers of a cell using Pulsed D.C Magnetron Sputtering (PDMS) from powder targets.

References

[2] E. Elliott, R.D. Tomlinson, J. Parkes, M.J. Hampshire, Thin Solid Films, 20 (1974) S25-S26.



Materials Deposited

- 1. Molybdenum (back contact)
- 2. Copper indium diselenide (absorber layer)
- 3. Indium sulphide (buffer layer)
- 4. Indium oxide (Transparent Conductive Oxide layer)



Sputtered in argon atmosphere from commercial Mo powder.

Films sputtered at different substrate temperatures

Molybdenum Films



XRD of Mo Films





Deposition Parameters

Pressure : $7.0x10^{-3}$ mbar Mode : Constant Power (50W) Frequency : 75 kHz Pulse off Time : 0.5 µs Distance : 10 cm

Body-centred cubic phase

With increase in substrate temperature

A shift in 2θ towards higher angles was noticed.

Reference

Films, 2011, accepted for publication.

S. Karthikeyan et al, Nano-structured features of pulsed d.c magnetron sputtered Mo films for photovoltaic application Thin Solid



Strain Analysis of Mo Films



Strain % reduced with increase in temperature



Resistivity Analysis of Mo Films



Resistivity reduced with increase in temperature



SEM and AFM Studies of Mo Films



Morphological change from a cluster of small grains to a fibrous, columnar needle-like structure for films grown at 150 °C

References

Al-Thani, H.A et al, 2002, Twenty-Ninth IEEE Photovoltaic Specialist Conference, pp 720-3.



Sputtered in argon atmosphere from our CulnSe₂ powder.

Films sputtered from CIS powder with different compositions

Copper Indium Diselenide Films



CuInSe₂ Crystal Growth

Selenium, Indium and Copper inside quartz tube before sealing

CuInSe₂ inside ampoule after direct fusion



References

S.Karthikeyan et al, Thin Solid Films, 2011, 519; pp.3107 -3112



XRD of CuInSe₂ Films





Deposition Parameters

Pressure : 7.5x10⁻³ mbar Mode : Constant Current (0.12A Frequency : 130 kHz Pulse off Time : 1.0 µs Distance : 10 cm

Reference

S.Karthikeyan et al, Thin Solid Films, 2011, 519; pp.3107 -3112

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Ternary Diagram of CuInSe₂ Films and Powder



S.Karthikeyan et al, Thin Solid Films, 2011, 519; pp.3107 -3112



Optical Studies of CuInSe₂ Films



Band gap is very close to the reported value of 1.02 eV



Sputtered in argon atmosphere from commercial In₂S₃ powder.

Films sputtered at different substrate temperatures

Indium Sulphide Films

University of Salford

XRD of In₂S₃Films





Deposition Parameters

Pressure : $7.3x10^{-3}$ mbar Mode : Constant Power (25 W) Frequency : 100 kHzPulse off Time : 0.5μ s Distance : 8 cm

Preferred (109) orientation Tetragonal $-\beta In_2S_3$ formed with No heating !!



Optical and AFM studies of In₂S₃ Films



Band gap decreased with decrease in sulphur content

Deposition Temperature	% In	%s	$\frac{[\%S]}{[\%In]}$	Band Gap eV
Non heated	41.26	58.74	1.42	2.768
100 °C	41.84	58.16	1.39	2.735
150 °C	42.86	57.14	1.33	2.708
200 °C	43.5	56.5	1.29	2.667
250 °C	48.51	51.49	1.20	2.526



Reactive sputtered in oxygen and argon atmosphere from commercial In_2O_3 powder.

Films sputtered at different oxygen flow rates with no additional heating

Indium Oxide Films



In₂O₃ Films

X-ray diffraction spectra





Deposition Parameters

Pressure : $4.0x10^{-3}$ Pa Mode : Constant Power (60W) Frequency : 60 kHzPulse off Time : 0.5μ s Distance : 9 cmMFC : $F_{Ar} + F_{Oxygen} = 20 \text{ sccm}$ Thickness ~ 500 nm

Cubic bixbyite In₂O₃ phase.

Preferred (400) (440) orientation at higher O₂ concentration



Resistivity of In₂O₃ Films



Strongly n-type 0 - 2.5% O₂

Weakly n-type 5 – 10% O₂



Optical Properties of In₂O₃ Films





AFM of In₂O₃ Films



References

Y.C Liang et al, Appl Phys A, 2009, 97; pp.249-255.



Conclusion

> The possibilities of pulsed d.c magnetron sputtering for the deposition of Mo, $CuInSe_2 In_2S_3$ and In_2O_3 films from powdered targets were studied.

 \succ The analysis showed that these PDMS grown films can be used for solar cell applications.

➤ The most surprising outcome is the nearly stoichometric nature of the CIS films <u>largely irrespective of the starting composition of the material</u>

> Single phase CIS and In_2S_3 films were produced using PDMS technique without the aid of additional substrate heating.

 \succ Films grown from this single step process can cut down the cost and also the dangerous selenisation processes that have previously been associated with the production of high efficiency CIS solar cells.







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THANK FOR YOUR ATTENTION Questions ?





Pulsed D.C. Magnetron Sputtering System



S. Karthikeyan et al, Vacuum, 2010, 85; pp.634-638.



SEM and AFM CuInSe₂ Films

~180-210 nm particle size

